Search Notes



Application/Control No.

Applicant(s)/Patent Under

Reexamination

LIN, JYUN-NAIH

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Art Unit

Examiner

2616

Moutaouakil, Mounir

SEARCHED

Class	Subclass	Date	Examiner
370	392.54	6/30/2007	MM
370	392.52	6/30/2007	MM
370	351	6/30/2007	MM
370 ·	473	6/30/2007	MM
370	474	6/30/2007	MM
370	475	6/30/2007	MM
370	476	6/30/2007	MM
379	219	6/30/2007	MM
379	220	6/30/2007	MM
379	242	6/30/2007	MM
709	235	6/30/2007	MM
709	236	6/30/2007	MM
709	238	6/30/2007	MM
709	242	6/30/2007	MM
709	245	6/30/2007	MM

SEARCH NOTES

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Search Notes	Date	Examiner	
Consulted with Hassan Kizou (SPE)		MM	
IEEE Xplore		MM	
WIPO		MM	
Inventorship search		MM	
EAST		MM	

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner